NCP51200

Product Preview

3 Amp Source / Sink V_{TT} Termination Regulator for DDR, DDR-2, DDR-3, DDR-4

The NCP51200 is a source/sink Double Data Rate (DDR) termination regulator specifically designed for low input voltage and low−noise systems where space is a key consideration.

The NCP51200 maintains a fast transient response and only requires a minimum output capacitance of 20 μF. The NCP51200 supports a remote sensing function and all power requirements for DDR V_{TT} bus termination. The NCP51200 can also be used in low−power chipsets and graphics processor cores that require dynamically adjustable output voltages.

The NCP51200 is available in the thermally−efficient DFN10 Exposed Pad package, and is rated both Green and Pb−free.

Features

- For Automotive Applications
- Input Voltage Rails: Supports 2.5 and 3.3 V Rails
- PV_{CC} Voltage Range: 1.1 to 3.5 V
- Integrated Power MOSFETs
- Fast Load−Transient Response
- P_{GOOD} − Logic output pin to Monitor V_{TT} Regulation
- EN − Logic input pin for Shutdown mode
- V_{RI} − Reference Input Allows for Flexible Input Tracking Either Directly or Through Resistor Divider
- Remote Sensing (V_{TTS})
- Built−in Soft Start, Under Voltage Lockout and Over Current Limit
- Thermal Shutdown
- Small, Low−Profile 10−pin, 3x3 DFN Package
- These are Pb−Free Devices

Applications

- DDR Memory Termination
- Desktop PC's, Notebooks, and Workstations
- Servers and Networking equipment
- Telecom/Datacom, GSM Base Station
- Graphics Processor Core Supplies
- Set Top Boxes, LCD−TV/PDP−TV, Copier/Printers
- Chipset/RAM Supplies as Low as 0.5 V
- Active Bus Termination

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.

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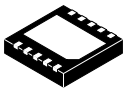


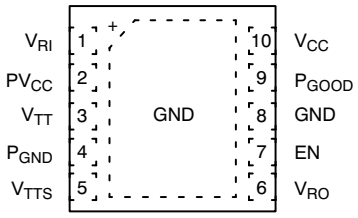
DFN10, 3x3, 0.5P
CASE 485C

MARKING DIAGRAM

XXXXX = Specific Device Code
A = Assembly Location
L = Wafer Lot
Y = Year
W = Work Week
▪ = Pb−Free Package

(Note: Microdot may be in either location)

PIN CONNECTION



Exposed Pad

ORDERING INFORMATION

Device	Package	Shipping†
NCP51200MNTWG	DFN10 (Pb−Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PIN FUNCTION DESCRIPTION

Pin Number	Pin Name	Pin Function
1	V_{RI}	V_{TT} External Reference Input (set to V_{DDQ} / 2 thru resistor network).
2	PV_{CC}	Power input. Internally connected to the output source MOSFET.
3	V_{TT}	Power Output of the Linear Regulator.
4	P_{GND}	Power Ground. Internally connected to the output sink MOSFET.
5	V_{TTS}	V_{TT} Sense Input. The V_{TTS} pin provides accurate remote feedback sensing of V_{TT}. Connect V_{TTS} to the remote DDR termination bypass capacitors.
6	V_{RO}	Independent Buffered V_{TT} Reference Output. Sources and sinks over 5 mA. Connect to GND thru 0.1 μF ceramic capacitor.
7	EN	Shutdown Control Input. CMOS compatible input. Logic high = enable, logic low = shutdown. Connect to V_{DDQ} for normal operation.
8	GND	Common Ground.
9	P_{GOOD}	Power Good (Open Drain output).
10	V_{CC}	Analog power supply input. Connect to GND thru a 1 - 4.7 μF ceramic capacitor.
	THERMAL PAD	Pad for thermal connection. The exposed pad must be connected to the ground plane using multiple vias for maximum power dissipation performance.

ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
V_{CC}, PV_{CC}, V_{TT}, V_{TTS}, V_{RI}, V_{RO} (Note 1)		−0.3 to 3.6	V
EN, P_{GOOD} (Note 1)		−0.3 to 6.5	V
P_{GND} to GND (Note 1)		−0.3 to +0.3	V
Storage Temperature	T_{STG}	−55 to 150	°C
Operating Junction Temperature Range	T_J	125	°C
ESD Capability, Human Body Model (Note 2)	ESD_{HBM}	2000	V

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Refer to ELECTRICAL CHARACTERISTICS and APPLICATION INFORMATION for Safe Operating Area.
2. This device series incorporates ESD protection and is tested by the following method:
   ESD Human Body Model tested per AEC−Q100−002 (EIA/JESD22−A114)
   ESD Machine Model tested per AEC−Q100−003 (EIA/JESD22−A115)
   Latchup Current Maximum Rating tested per JEDEC standard: JESD78.

DISSIPATION RATINGS

Package	T_A = 25°C Power Rating	Derating Factor above T_A = 25°C	T_A = +85°C Power Rating
10−Pin DFN	1.92 W	19 mW/°C	0.79 W

RECOMMENED OPERATING CONDITIONS

Rating	Symbol	Value	Unit
Supply Voltage	V_{CC}	2.375 to 3.5	V
Voltage Range	V_{RO}	−0.1 to 1.8	V
	V_{RI}	0.5 to 1.8	
	PV_{CC}, V_{TT}, V_{TTS}, EN, P_{GOOD}	−0.1 to 3.5	
	P_{GND}	−0.1 to +0.1	
Reference Input Voltage	T_A	−40 to +125	°C

ELECTRICAL CHARACTERISTICS

$-40°C \le T_A \le 125°C$; V_{CC} = 3.3 V; PV_{CC} = 1.8 V; $V_{RI} = V_{TTS}$ = 0.9 V; EN = V_{CC}; C_{OUT} = 3 x 10 μF (Ceramic); unless otherwise noted.

Parameter	Conditions	Symbol	Min	Typ	Max	Units
Supply Current						
V_{CC} Supply Current	T_A = +25°C, EN = 3.3 V, No Load	I_{VCC}		0.7	1	mA
V_{CC} Shutdown Current	T_A = +25°C, EN = 0 V, V_{RI} = 0 V, No Load	$I_{VCC\ SHD}$		65	80	μA
	T_A = +25°C, EN = 0 V, V_{RI} < 0.4 V, No Load			200	400	
V_{CC} UVLO Threshold	Wake−up, T_A = +25°C	V_{UVLO}	2.2	2.3	2.375	V
	Hysteresis			50		mV
PV_{CC} Supply Current	T_A = +25°C, EN = 3.3 V, No Load	I_{PVCC}		1	50	μA
PV_{CC} Shutdown Current	T_A = +25°C, EN = 0 V, No Load	$I_{PVCC\ SHD}$		0.1	50	μA
V_{TT} Output						
V_{TT} Output Offset Voltage	V_{RO} = 1.25 V (DDR1), I_{TT} = 0 A	V_{OS}	−15		+15	mV
	V_{RO} = 0.9 V (DDR2), I_{TT} = 0 A		−15		+15	
	PV_{CC} = 1.5 V, V_{RO} = 0.75 V (DDR3), I_{TT} = 0 A		−15		+15	
V_{TT} Voltage Tolerance to V_{RO}	$-2\ A \le I_{TT} \le +2\ A$		−25		+25	mV
Source Current Limit	V_{TTS} = 90% * V_{RO}		3		4.5	A
Sink Current Limit	V_{TTS} = 110% * V_{RO}		3.5		5.5	A
Soft−start Current Limit Timeout		T_{SS}		200		μs
Discharge MOSFET On−resistance	V_{RI} = 0 V, V_{TT} = 0.3 V, EN = 0 V, T_A = +25°C	R_{DIS}		18	25	Ω
V_{RI} − Input Reference						
V_{RI} Voltage Range		V_{RI}	0.5		1.8	V
V_{RI} Input−bias Current	EN = 3.3 V	I_{RI}			+1	μA
V_{RI} UVLO Voltage	V_{RI} rising	$V_{RI\ UVLO}$	360	390	420	mV
	Hysteresis	$V_{RI\ HYS}$		20		
V_{RO} − Output Reference						
V_{RO} Voltage				V_{RI}		V
V_{RO} Voltage Tolerance to V_{RI}	I_{RO} = ±10 mA, $0.6\ V \le V_{RI} \le 1.25\ V$		−15		+15	mV
V_{RO} Source Current Limit	V_{RO} = 0 V		10	40		mA
V_{RO} Sink Current Limit	V_{RO} = 0 V		10	40		mA
P_{GOOD} − Powergood Comparator						
P_{GOOD} Lower Threshold	(with respect to V_{RO})		−23.5 %	−20%	−17.5 %	V/V
P_{GOOD} Upper Threshold	(with respect to V_{RO})		17.5%	20%	23.5%	
P_{GOOD} Hysteresis				5%		
P_{GOOD} Start−up Delay	Start−up rising edge, V_{TTS} within 15% of V_{RO}			2		ms
P_{GOOD} Leakage Current	$V_{TTS} = V_{RI}$ (P_{GOOD} = True) $P_{GOOD} = V_{CC}$ + 0.2 V			1		μA
P_{GOOD} = False Delay	V_{TTS} is beyond ±20% P_{GOOD} trip thresholds			10		μs
P_{GOOD} Output Low Voltage	I_{GOOD} = 4 mA			0.4		V
EN − Enable Logic						
Logic Input Threshold	EN Logic high	V_{IH}		1.7		V
	EN Logic low	V_{IL}		0.3		

ELECTRICAL CHARACTERISTICS

$-40°C \le T_A \le 125°C$; V_{CC} = 3.3 V; PV_{CC} = 1.8 V; $V_{RI} = V_{TTS}$ = 0.9 V; EN = V_{CC}; C_{OUT} = 3 x 10 μF (Ceramic); unless otherwise noted.

Parameter	Conditions	Symbol	Min	Typ	Max	Units
Hysteresis Voltage	EN pin	V_{ENHYS}		0.5		V
Logic Leakage Current	EN pin, T_A = +25°C	I_{ILEAK}	−1		+1	μA
Thermal Shutdown						
Thermal Shutdown Temperature		T_{SD}		150		°C
Thermal Shutdown Hysteresis		T_{SH}		25		°C

General

The NCP51200 is a sink/source tracking termination regulator specifically designed for low input voltage and low external component count systems where space is a key application parameter. The NCP51200 integrates a high-performance, low-dropout (LDO) linear regulator that is capable of both sourcing and sinking current. The LDO regulator employs a fast feedback loop so that small ceramic capacitors can be used to support the fast load transient response. To achieve tight regulation with minimum effect of trace resistance, a remote sensing terminal, V_{TTS}, should be connected to the positive terminal of the output capacitors as a separate trace from the high current path from V_{TT}.

V_{RI} - Generation of Internal Voltage Reference

The output voltage, V_{TT}, is regulated to V_{RO}. When V_{RI} is configured for standard DDR termination applications, V_{RI} can be set by an external equivalent ratio voltage divider connected to the memory supply bus (V_{DDQ}). The NCP51200 supports V_{RI} voltage from 0.5 V to 1.8 V, making it versatile and ideal for many types of low-power LDO applications.

V_{RO} - Reference Output

When it is configured for DDR termination applications, V_{RO} generates the DDR V_{TT} reference voltage for the memory application. It is capable of supporting both a sourcing and sinking load of 10 mA. V_{RO} becomes active when V_{RI} voltage rises to 420 mV* and V_{CC} is above the UVLO threshold. When V_{RO} is less than 360 mV, it is disabled and subsequently discharges to GND through an internal 10−kΩ MOSFET. V_{RO} is independent of the EN pin state.

*NOTE: Typical values are used with the application description text. Please refer to the Electrical Specifications Table for a more detailed list of MIN, MAX and TYPICAL values.

Soft Start

The soft-start function of the V_{TT} pin is achieved via a current clamp. The current clamp allows the output capacitors to be charged with low and constant current, providing a linear ramp-up of the output voltage. When

V_{TT} is outside of the power good window, the current clamp level is one-half of the full over-current limit (OCL) level. When V_{TT} rises or falls within the P_{GOOD} window, the current clamp level switches to the full OCL level.

The soft-start function is completely symmetrical; it works not only from GND to the V_{RO} voltage but also from PV_{CC} to the V_{RO} voltage.

EN - Enable Control

When EN is driven high, the NCP51200 V_{TT} regulator begins normal operation. When EN is driven low, V_{TT} is discharges to GND through an internal 18−Ω MOSFET. V_{REF} remains on when EN is driven low.

P_{GOOD} - PowerGood

The NCP51200 provides an open-drain P_{GOOD} output that goes high when the V_{TT} output is within ±20% of V_{RO}. P_{GOOD} de-asserts within 10 μs after the output exceeds the limits of the PowerGood window. During initial V_{TT} startup, P_{GOOD} asserts high 2 ms after the V_{TT} enters power good window. Because P_{GOOD} is an open−drain output, a 100 kΩ, pull−up resistor between P_{GOOD} and a stable active supply voltage rail is required.

The LDO has a constant over-current limit (OCL). Note that the OCL level reduces by one-half when the output voltage is not within the power good window. This reduction is non-latch protection. For V_{CC} under-voltage lockout (UVLO) protection, the NCP51200 monitors V_{CC} voltage. When the V_{CC} voltage is lower than the UVLO threshold voltage, both the V_{TT} and V_{RO} regulators are powered off. This shutdown is also non-latch protection.

Thermal Shutdown with Hysteresis

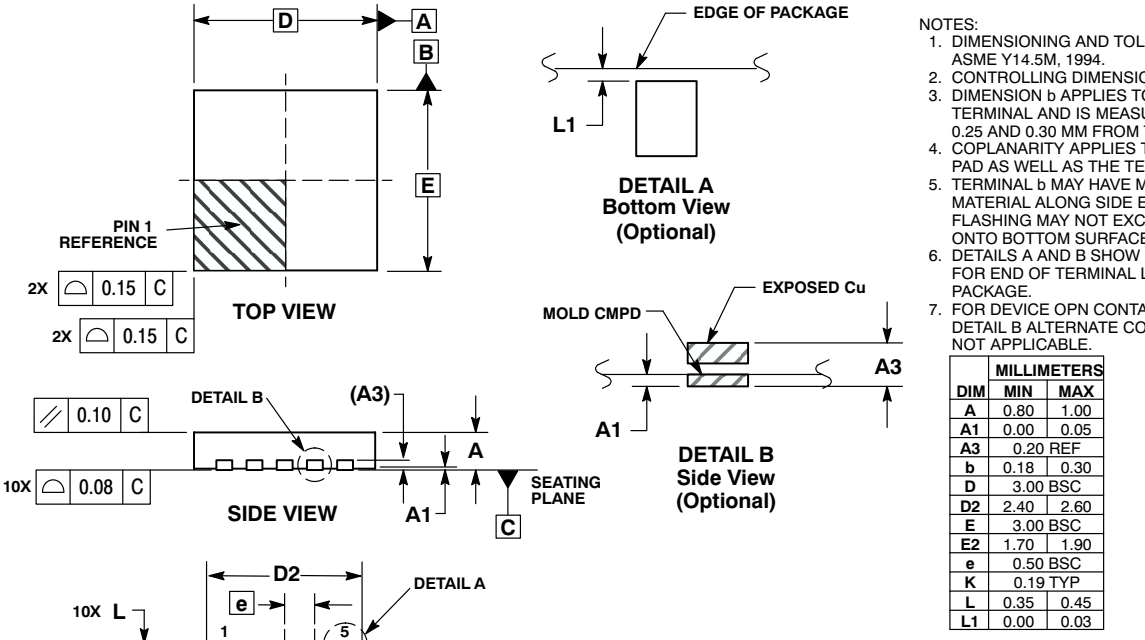
If the NCP51200 is to operate in elevated temperatures for long durations, care should be taken to ensure that the maximum operating junction temperature is not exceeded. To guarantee safe operation, the NCP51200 provides on−chip thermal shutdown protection. When the chip junction temperature exceeds 150°C, the part will shutdown. When the junction temperature falls back to 125°C, the device resumes normal operation. If the junction temperature exceeds the thermal shutdown threshold then the V_{TT} and V_{RO} regulators are both shut off, discharged by the internal discharge MOSFETs. The shutdown is a non-latch protection.

Tracking Startup and Shutdown

The NCP51200 also supports tracking startup and shutdown when EN is tied directly to the system bus and not used to turn on or turn off the device. During tracking startup, V_{TT} follows V_{RO} once V_{RI} voltage is greater than 420 mV. V_{RI} follows the rise of V_{DDQ} memory supply rail via a voltage divider. The typical soft-start time for the V_{DDQ} memory supply rail is approximately 3 ms, however it may vary depending on the system configuration. The SS time of the V_{TT} output no longer depends on the OCL setting, but it is a function of the SS time of the V_{DDQ} memory supply rail. P_{GOOD} is asserted 2 ms after V_{TT} is within ±20% of V_{RO}. During tracking shutdown, V_{TT} falls following V_{RO} until V_{RO} reaches 360 mV. Once V_{RO} falls below 360 mV, the internal discharge MOSFETs are turned on and quickly discharge both V_{RO} and V_{TT} to GND. P_{GOOD} is de-asserted once V_{TT} is beyond the ±20% range of V_{RO}.

PACKAGE DIMENSIONS

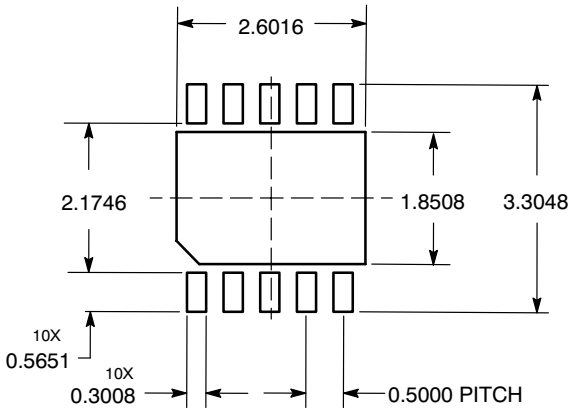
DFN10, 3x3, 0.5P
CASE 485C
ISSUE C



NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM TERMINAL.
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
5. TERMINAL b MAY HAVE MOLD COMPOUND MATERIAL ALONG SIDE EDGE. MOLD FLASHING MAY NOT EXCEED 30 MICRONS ONTO BOTTOM SURFACE OF TERMINAL b.
6. DETAILS A AND B SHOW OPTIONAL VIEWS FOR END OF TERMINAL LEAD AT EDGE OF PACKAGE.
7. FOR DEVICE OPN CONTAINING W OPTION, DETAIL B ALTERNATE CONSTRUCTION IS NOT APPLICABLE.

	MILLIMETERS	
DIM	MIN	MAX
A	0.80	1.00
A1	0.00	0.05
A3	0.20 REF	
b	0.18	0.30
D	3.00 BSC	
D2	2.40	2.60
E	3.00 BSC	
E2	1.70	1.90
e	0.50 BSC	
K	0.19 TYP	
L	0.35	0.45
L1	0.00	0.03

SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS

*For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
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NCP51200/D